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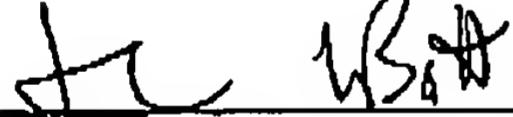
## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

OCT 07 2004

**Serial No.:** 10/647,714**Conf. No.:** 2476**Filing Date:** 08/25/2003**Art Unit:** 2818**Applicant:** Khan et al.**Examiner:** Le, Thao P.**Title:** METAL OXIDE SEMICONDUCTOR  
HETEROSTRUCTURE FIELD EFFECT  
TRANSISTOR**Docket No.:** SETI-0002DIV**COMMISSIONER FOR PATENTS****DESTINATION PHONE NUMBER:** 703-872-9306Transmitted herewith is: **Amendment in 10 pages**

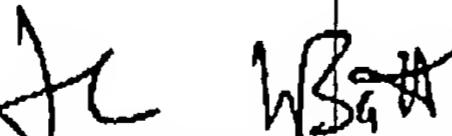
in the above identified application.

- No additional fee is required.
- The Commissioner is hereby authorized to charge and credit Deposit Account No. 500999 as described below.
- Credit any overpayment.
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 John W. LaBatt, Reg. No. 48,301
**DATE:** October 7, 2004**CERTIFICATION OF FACSIMILE TRANSMISSION**

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Title: METAL OXIDE SEMICONDUCTOR  
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TRANSISTOR

Docket No.: SETI-0002DIV

Mail Stop Amendment  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

AMENDMENT

Sir:

This paper is being filed in response to the Office Action dated July 14, 2004. Please amend the above-identified application as follows:

Listing of Claims begins on page 2 of this paper.

Remarks begin on page 7 of this paper.

Serial No. 10/647,714

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